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				Application Number	
				Filing Date	
				First Named Inventor	
				Group Art Unit	
Examiner Name				TI-29922.1	
Sheet	1	of	1	Attorney Docket No.	

U.S. PATENT DOCUMENTS						
Exam. Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Doc.	Date of Pub. of Cited Doc. (mm-dd-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
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Exam. Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Doc.	Date of Pub. of Cited Doc. (mm-dd-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Office ³	Number ⁴	Kind Code ² (if known)				
EON	BA	JP	B-172135	A	Miyagi	07/02/1996		
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NON PATENT LITERATURE DOCUMENTS			
Exam. Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
EON	CA	JP 8-172135 English Language Abstract (Miyagi) 1996-07-02, [online], [retrieved on 2002-11-13] Retrieved from the Industrial Property Digital Library of the Japanese Patent Office using Internet <URL: http://www.ipdl.jpo.go.jp/homepg_e.ipdl>	
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